

Rough layer scattering filled by elliptical cylinders from the method of moments combined with the characteristic basis function method and the Kirchoff approximation

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In this paper, the electromagnetic field scattered by several 2D scatterers of any shape is calculated rigorously from the boundary integral equations discretized by the method of moments with the point matching method and pulse basis functions. In addition, the resulting linear system is efficiently solved from the domain decomposition method named the characteristic basis function method. To accelerate the computation of the primary basis functions, which requires solving sublinear systems, the Kirchoff approximation is applied for metallic and dielectric objects. The efficiency of the method is tested on several applications met in practice: stack of rough interfaces separating homogeneous media, collection of metallic and dielectric elliptical cylinders, collection of coated elliptical cylinders, and a combination of the previous scenarios. © 2021 Optical Society of America

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1. INTRODUCTION

The study of the wave scattering from several scatterers of any shape is a subject of great interest. The applications of such research concern many areas such as remote sensing, radar surveillance, optics, and ocean acoustics.

For a collection of objects of canonical shape, like circular 26 cylinders (of infinite length) and spheres, the scattered field 27 28 can be computed analytically by introducing special functions, e.g., Bessel's and spherical Bessel's [1,2]. For elliptical cylinders 29 [3-5], Mathieu's functions [6] are introduced, but they are diffi-30 cult to program, unlike well-known Bessel's functions. Adding 31 a boundary, like a smooth plate of infinite area (space divided 32 into two media), the previous formulations can be extended 33 [7-17], and the difficulty of programming increases. For a stack 34 of rough interfaces separating homogeneous media, asymptotic 35 36 approaches, in which simplifying assumptions are introduced, have been developed. For small roughness, we can cite the small 37 perturbation method [18-24] and, for high roughness, the geo-38 metric optics approximation [25-27]. For a complex scenario, 39 like inhomogeneous (dielectric objects are present in the layer) 40 layered rough interfaces, it is difficult to derive a closed-form 41 42 expression of the scattered field.

The well-known method of moments (MoM) [28–31] is
a way of rigorously solving this type of scattering problem by
converting the boundary integral equations into a linear system,
in which the impedance matrix must be inverted to determine

the surface currents. However, the direct solution of the linear system through a direct lower upper (LU) decomposition is usually limited by $\mathcal{O}(N^3)$ and $\mathcal{O}(N^2)$ complexities in CPU time and memory requirements, respectively, where N is the number of unknowns. This is computationally expensive for an electrically large multiscale object or a collection of dielectric objects (i.e., many unknowns) and has led to develop iterative methods and/or domain decomposition methods that significantly reduce the storage and computation cost. Among the numerous publications addressing this issue, references [32–43] have shown the efficiency of these methods for the scattering from a stack of two or three rough interfaces and for an object near a rough interface.

The characteristic basis function method (CBFM), a domain decomposition method, has shown efficiency for scattering from a 3D metallic or dielectric object [40,43-45]. In this paper, this method is applied for the scattering from *P* 2D metallic and dielectric scatterers of any shape. The propagation inside layer expansion (PILE) method [46] and its updated versions [39,42] can be extended for this type of problem; however, the difficulty of programming significantly increases. Thus, this method is not chosen. In addition, the subdomain decomposition iterative method (SDIM) [45,47] applied on the scenarios presented in this paper does not converge.

The CBFM principle splits up the problem into subproblems of smaller size, each of them being solved separately by

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calculating the primary basis functions (PBFs). Next, the cou-73 74 pling between them is accounted for via the computation of 75 the characteristic matrix, which involves the coupling matri-76 ces between the subproblems. To accelerate the calculation 77 of PBFs, which requires one to solve sublinear systems, the Kirchoff approximation (KA) is applied for metallic and dielec-78 tric objects. The efficiency of the method is tested on several 79 applications met in practice: stack of rough interfaces separat-80 ing homogeneous media, collection of metallic and dielectric 81 elliptical cylinders, collection of coated elliptical cylinders, and a 82 combination of the previous scenarios. 83

84 The paper is organized as follows. Section 2 extends the MoM to P scatterers of any shape. Section 3 briefly summarizes 85 86 the CBFM. Section 4 addresses the KA approximation for the derivation of the PBFs. Section 5 presents numerical results on 87 88 four scenarios. The last section gives concluding remarks.

2. METHOD OF MOMENTS FOR SEVERAL 89 SCATTERERS 90

91 This section presents the MoM for solving the electromagnetic 92 wave scattering from several scatterers. For one and two scatterers, this approach is thoroughly explained in the textbook [30]. 93 94 To sum, the boundary integral equations are applied on each 95 scatterer and are discretized from the MoM by using the pointmatching method and the pulse basis function. This leads to 96 the linear system $\overline{Z}X = b$, in which \overline{Z} is the impedance matrix 97 of the two scatterers, \boldsymbol{b} is a vector related to the incident field 98 on the scatterers, and X the surface currents on the scatterers. 99 100 i.e., the unknowns of the problem. In this section, this approach is generalized to several scatterers. 101

A. Case of a Single Illuminated Scatterer 102

For a single scatterer as shown in Fig. 1, the impedance matrix is 103 104 expressed from four submatrices as

$$\bar{Z}_{11} = \begin{bmatrix} A_{11} & \bar{B}_{11} \\ \bar{C}_{11} & \bar{D}_{11} \end{bmatrix}.$$
 (1)

The matrix \bar{A}_{11} is the matrix obtained from the Neumann 105 boundary condition, i.e., when the scatterer is assumed to be 106 107 perfectly conducting (metallic), and the transverse electric 108 (TE) polarization is considered. It is calculated in the incident medium Ω_0 . The matrix \bar{B}_{11} is the matrix obtained from 109 the Dirichlet boundary condition, i.e., when the scatterer is 110 assumed to be perfectly conducting (metallic), and the trans-111 verse magnetic (TM) polarization is considered. It is calculated 112 in the incident medium Ω_0 . The matrices { \bar{C}_{11} , \bar{D}_{11} } are sim-113 ilar to the matrices $\{\bar{A}_{11}, \bar{B}_{11}\}$, but they are computed in the 114



Fig. 1. Scattering from a single scatterer.

medium Ω_1 . The elements of these four submatrices are given in 115 Appendix A. 116

The vector \boldsymbol{b}_1 is defined as

$$\boldsymbol{b}_{1} = \begin{bmatrix} \boldsymbol{b}_{1}' \\ \boldsymbol{0} \end{bmatrix} = \begin{bmatrix} \psi_{\text{inc}}(\boldsymbol{r}_{1}) \dots \psi_{\text{inc}}(\boldsymbol{r}_{N_{1}}) \underbrace{0 \dots 0}_{N_{1} \text{ times}} \\ \underbrace{\boldsymbol{b}_{1}^{\text{T}}, \boldsymbol{r} \in S_{1}} \end{bmatrix}^{\text{T}}, \quad (2)$$

where ψ_{inc} is the incident wave illuminating the scatterer. The 118 symbol T stands for the transpose operator, and N_1 is the num-119 ber of discretization points on the surface S_1 of the object. This 120 means that the size of the matrix is $2N_1 \times 2N_1$. 121 122

The unknown vector X_1 of length $2N_1$ is expressed as

$$\boldsymbol{X}_{1} = \left[\psi_{1}(\boldsymbol{r}_{1}) \dots \psi_{1}(\boldsymbol{r}_{N_{1}}) \ \frac{\partial \psi_{1}(\boldsymbol{r}_{1})}{\partial n} \dots \frac{\partial \psi_{1}(\boldsymbol{r}_{N_{1}})}{\partial n} \right]^{\mathrm{T}} \quad \boldsymbol{r}_{\rho \in [1; N_{1}]} \in S_{1},$$
(3)

where $\partial \psi_1 / \partial n = \nabla \psi_1 \cdot \hat{n}_1$ is the normal derivative, in which 123 $\hat{\boldsymbol{n}}_1$ is the unitary vector normal to S_1 . The unknown \boldsymbol{X}_1 on S_1 is 124 computed from $X_1 = \bar{Z}_{11}^{-1} b_1$. The scattered field $\bar{\psi}_{sca}(r)$ in the 125 medium $r \in \Omega_0$ is then obtained from the Huygens principle 126 expressed as 127

$$\bar{\boldsymbol{\psi}}_{\rm sca}(\boldsymbol{r}) = -\bar{\boldsymbol{P}}(\boldsymbol{r},\,\boldsymbol{r}_1)\boldsymbol{X}_1,\tag{4}$$

where

$$\bar{\boldsymbol{P}}(\boldsymbol{r},\,\boldsymbol{r}_1) = \begin{bmatrix} \bar{\boldsymbol{A}}_{ij} \\ \bar{\boldsymbol{B}}_{ij} \end{bmatrix}_{\boldsymbol{r}_j = \boldsymbol{r}_1,\,\boldsymbol{r}_i = \boldsymbol{r}},\tag{5}$$

and $r_1 \in S_1$ $(r \neq r_1)$. If $r \in \Omega_1$ $(r \neq r_1)$; then, Eq. (4) is 129 applied by taking the plus sign (instead of minus). The matrices 130 $\{A_{ij}, B_{ij}\}$ are expressed in Appendix A. 131

The matrix $\bar{P}(r, r_1)$ propagates the surface currents 132 $\{\psi_1, \partial \psi_1 / \partial n\}$ from r_1 to r. Its size is $N_{\text{sca}} \times (2N_1)$, where 133 $N_{\rm sca}$ is the number of observation points and $\psi_{\rm sca}$ is a vector of 134 length $N_{\rm sca}$. 135

In the far field $(kr \gg 1)$, where k is the wavenumber of the 136 medium), the propagation matrix can be simplified as [30] 137

$$\bar{\boldsymbol{P}}^{\infty}(\boldsymbol{r},\,\boldsymbol{r}_{1}) = \frac{j}{4}\sqrt{\frac{2}{\pi\,kr}}$$

$$e^{-j(\pi/4+kr)} \begin{bmatrix} jv_{1}\boldsymbol{k}_{\text{sca}}\cdot\hat{\boldsymbol{n}}_{1}e^{-j\boldsymbol{k}_{\text{sca}}\cdot\boldsymbol{r}_{1}}\sqrt{1+\gamma_{1}^{2}}\Delta_{1}\\ e^{-j\boldsymbol{k}_{\text{sca}}\cdot\boldsymbol{r}_{1}}\sqrt{1+\gamma_{1}^{2}}\Delta_{1} \end{bmatrix},$$
(6)

where $\mathbf{k}_{sca} = k(\hat{\mathbf{x}} \sin \theta_{sca} + \hat{\mathbf{z}} \cos \theta_{sca})$ (see Fig. 1) stands for the 138 direction of observation, γ_1 the slope of S_1 at the point r_1 , Δ_1 139 its sampling step, and $v_1 = \operatorname{sgn}(\hat{\boldsymbol{n}}_1 \cdot \hat{\boldsymbol{z}})$ (sgn stands for the sign 140 function). 141

The radar cross section (RCS) is written as [30]

$$\mathbf{R}\mathbf{\bar{C}S} = \lim_{r \to \infty} 2\pi r \left| \mathbf{\bar{\psi}}_{sca}(\mathbf{r}) \right|^{2}$$
$$= \frac{1}{4k} \left| \begin{bmatrix} j v_{1} \mathbf{k}_{sca} \cdot \hat{\mathbf{n}}_{1} e^{-j\mathbf{k}_{sca} \cdot \mathbf{r}_{1}} \sqrt{1 + \gamma_{1}^{2}} \Delta_{1} \\ e^{-j\mathbf{k}_{sca} \cdot \mathbf{r}_{1}} \sqrt{1 + \gamma_{1}^{2}} \Delta_{1} \end{bmatrix} \mathbf{X}_{1} \right|^{2}, \quad \textbf{(7)}$$

where RCS is a vector of the same length as $\bar{\psi}_{sca}(r)$.

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$$\mathbf{NRCS} = \lim_{r \to \infty} \frac{r}{2\eta_0} \frac{\left| \boldsymbol{\psi}_{\mathrm{sca}}(\boldsymbol{r}) \right|^2}{p_{\mathrm{inc}}}, \qquad (8)$$

is

146 where η_0 is the wave impedance of medium Ω_0 and p_{inc} the incident power. For an incident plane wave of unitary amplitude, 147 $p_{\rm inc} = L \cos \theta_{\rm inc} / (2\eta_0)$, so that **NRCS** = **RCS** $\cos \theta_{\rm inc} / (2\pi L)$. 148

149 B. Case of P Illuminated Scatterers

For the case of two illuminated scatterers (Fig. 2, with P = 2), 150 the impedance matrix \bar{Z} is expressed as [30] 151

$$\bar{Z} = \begin{bmatrix} \bar{Z}_{11} \ \bar{Z}_{12}^{(1)} \\ \bar{Z}_{21}^{(1)} \ \bar{Z}_{22} \end{bmatrix},$$
(9)

where \bar{Z}_{11} [Eq. (1)] and \bar{Z}_{22} are the self-impedance matrices of 152 scatterers 1 and 2, respectively. The matrix \bar{Z}_{22} is obtained from 153 \overline{Z}_{11} by changing (S_1, k_1) to (S_2, k_2) , where $k_i = k_0 \sqrt{\epsilon_{r,i}}$ is the 154 wavenumber of the medium Ω_i of relative permittivity $\epsilon_{r,i}$. In 155 156 addition, $k_0 = 2\pi/\lambda_0$ is the wavenumber in vacuum and λ_0 the wavelength in vacuum. 157

The coupling (interaction between two different scatterers) 158 matrices $\bar{Z}_{12}^{(1)}$ (of size $2N_1 \times 2N_2$) and $\bar{Z}_{21}^{(1)}$ (of size $2N_2 \times 2N_1$) 159 are written as 160

$$\bar{\boldsymbol{Z}}_{12}^{(1)} = \begin{bmatrix} \bar{\boldsymbol{A}}_{12} & \bar{\boldsymbol{B}}_{12} \\ \bar{\boldsymbol{0}}_{N_1 \times N_2} & \bar{\boldsymbol{0}}_{N_1 \times N_2} \end{bmatrix}, \ \bar{\boldsymbol{Z}}_{21}^{(1)} = \begin{bmatrix} \bar{\boldsymbol{A}}_{21} & \bar{\boldsymbol{B}}_{21} \\ \bar{\boldsymbol{0}}_{N_2 \times N_1} & \bar{\boldsymbol{0}}_{N_2 \times N_1} \end{bmatrix},$$
(10)

where $ar{\mathbf{0}}$ is a null matrix. The size of the matrix $ar{Z}$ is 161 162 $2(N_1 + N_2) \times 2(N_1 + N_2)$, where N_i $(i = \{1, 2\})$ is the number of discretization points on the surface S_i of the object. 163 The elements of the submatrices $\{\bar{A}_{12}, \bar{B}_{12}\}$ can be found in 164 Appendix A. 165

If scatterer 2 is perfectly conducting (metallic), then 166 $\bar{\boldsymbol{Z}}_{22} = \bar{\boldsymbol{P}}_{22}, \ \bar{\boldsymbol{Z}}_{12}^{(1)} = [\bar{\boldsymbol{P}}_{12} \, \bar{\boldsymbol{0}}]^{\mathrm{T}} \text{ and } \bar{\boldsymbol{Z}}_{21}^{(1)} = [\bar{\boldsymbol{A}}_{21} \, \bar{\boldsymbol{B}}_{21}], \text{ where } \bar{\boldsymbol{P}}_{ij} = \{\bar{\boldsymbol{A}}_{ij}, \, \bar{\boldsymbol{B}}_{ij}\} \text{ for the TM } (\partial \psi_2 / \partial n = 0) \text{ and TE } (\psi_2 = 0) \text{ polarizations, respectively. In addition, if the scatterer 1 is per-$ 167 168 169 fectly conducting, then $\bar{Z}_{12,21}^{(1)} = \bar{P}_{12,21}$ and $\bar{Z}_{11,22} = \bar{P}_{11,22}$. 170 The size of \overline{Z} is reduced to $(N_1 + N_2) \times (N_1 + N_2)$. 171

The excitation vector **b** of length $2(N_1 + N_2)$ is written as 172



Fig. 2. Scattering from *P* illuminated scatterers.

where the vector \boldsymbol{b}_i is defined from Eq. (2).

The unknown vector **X** of length $2(N_1 + N_2)$ is expressed as 174

$$\boldsymbol{X} = \left[\boldsymbol{X}_1 \ \boldsymbol{X}_2 \right]^{\mathrm{T}}, \tag{12}$$

where X_i is expressed from Eq. (3). The unknown X on $S_1 \cup S_2$ 175 is computed from $X = \bar{Z}^{-1} b$. 176

The scattered field $\bar{\psi}_{sca}(\mathbf{r})$ in the medium $\mathbf{r} \in \Omega_0$ ($\mathbf{r} \notin S_i$) is then obtained from the Huygens principle expressed as

$$\bar{\boldsymbol{\psi}}_{sca}(\boldsymbol{r}) = -\begin{bmatrix} \bar{\boldsymbol{P}}(\boldsymbol{r}, \, \boldsymbol{r}_1) \\ \bar{\boldsymbol{P}}(\boldsymbol{r}, \, \boldsymbol{r}_2) \end{bmatrix} \boldsymbol{X}.$$
(13)

If $\mathbf{r} \in \Omega_1$ ($\mathbf{r} \notin S_1$), then the above equation is applied by taking the plus sign on the matrix $\bar{P}(r, r_1)$ (instead of minus). If $\mathbf{r} \in \Omega_2$ ($\mathbf{r} \notin S_2$), then the above equation is applied by taking the plus sign on the matrix $\bar{P}(r, r_2)$.

In this paper, the formulation is generalized to P scatterers. The impedance matrix is then expressed as

$$\bar{Z} = \begin{bmatrix} \bar{Z}_{11} & \bar{Z}_{12}^{(1)} & \dots & \bar{Z}_{1P}^{(1)} \\ \bar{Z}_{21}^{(1)} & \bar{Z}_{22} & \dots & \bar{Z}_{2P}^{(1)} \\ \vdots & \vdots & \ddots & \vdots \\ \bar{Z}_{P1}^{(1)} & \bar{Z}_{P2}^{(1)} & \dots & \bar{Z}_{PP} \end{bmatrix},$$
(14)

where \bar{Z}_{ii} is the self-impedance matrix of the scatterer *i*, whereas 185 $\bar{Z}_{ij}^{(1)}$ is the coupling matrix between the objects *i* and *j* (propagation of the scattered field from *j* to *i*) expressed from Eq. (10). 186 187 The size of the matrix \bar{Z} is $N \times N$ where $N = 2 \sum_{i=1}^{i=P} N_i$. 188 189

The excitation vector **b** of length N is written as

$$\boldsymbol{b} = \begin{bmatrix} \boldsymbol{b}_1 \ \boldsymbol{b}_2 \ \dots \ \boldsymbol{b}_P \end{bmatrix}^{\mathrm{I}}, \qquad (15)$$

where the vector \boldsymbol{b}_i is defined by Eq. (2). The unknown vector \boldsymbol{X} 190 of length N is 191

$$\boldsymbol{X} = \left[\boldsymbol{X}_1 \; \boldsymbol{X}_2 \ldots \boldsymbol{X}_P \; \right]^{\mathrm{T}}, \tag{16}$$

where X_i is expressed from Eq. (3) and computed by solving the 192 linear system ZX = b. 193

The scattered field $\bar{\boldsymbol{\psi}}_{sca}(\boldsymbol{r})$ in the medium $\boldsymbol{r} \in \Omega_0$ ($\boldsymbol{r} \notin S_i$) is 194 then obtained from the Huygens principle expressed as 195

$$\bar{\boldsymbol{\psi}}_{sca}(\boldsymbol{r}) = -\begin{bmatrix} \boldsymbol{P}(\boldsymbol{r}, \boldsymbol{r}_1) \\ \bar{\boldsymbol{P}}(\boldsymbol{r}, \boldsymbol{r}_2) \\ \vdots \\ \bar{\boldsymbol{P}}(\boldsymbol{r}, \boldsymbol{r}_p) \end{bmatrix} \boldsymbol{X}.$$
 (17)

For $\mathbf{r} \in \Omega_i$ $(i \neq 0 \text{ and } \mathbf{r} \notin S_i)$, the above equation is applied 196 by taking the plus sign on the matrix $\bar{P}(r, r_i)$ (instead of 197 minus). 198

C. Case of P Illuminated Scatterers Where Only One Is Illuminated

For the case of two illuminated scatterers where only one is 201 illuminated (Fig. 3 with P = 2), the impedance matrix \bar{Z} is 202 expressed as [30] 203

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Fig. 3. P illuminated scatterers where only one is illuminated (the scatterer 1).

$$\bar{Z} = \begin{bmatrix} \bar{Z}_{11} & \bar{Z}_{12}^{(2)} \\ \bar{Z}_{21}^{(2)} & \bar{Z}_{22} \end{bmatrix},$$
(18)

204 where the coupling matrices $\bar{Z}_{12}^{(2)}$ and $\bar{Z}_{21}^{(2)}$ are written as

$$\bar{Z}_{12}^{(2)} = \begin{bmatrix} \bar{\mathbf{0}}_{N_1 \times N_2} & \bar{\mathbf{0}}_{N_1 \times N_2} \\ \bar{A}_{12} & \bar{B}_{12} \end{bmatrix}, \ \bar{Z}_{21}^{(2)} = \begin{bmatrix} \bar{A}_{21} & \bar{D}_{21} \\ \bar{\mathbf{0}}_{N_2 \times N_1} & \bar{\mathbf{0}}_{N_2 \times N_1} \end{bmatrix},$$
(19)

where $\mathbf{\bar{0}}$ is a null matrix. The size of the matrix $\mathbf{\bar{Z}}$ is $206 \qquad 2(N_1 + N_2) \times 2(N_1 + N_2)$. The elements of the submatrix $\mathbf{\bar{D}}_{21}$ can be found in Appendix A. It is important to note that the matrices $\mathbf{\bar{Z}}_{12}^{(2)}$ and $\mathbf{\bar{Z}}_{21}^{(2)}$ differ from those given by Eq. (10). If scatterer 2 is perfectly conducting (metallic), then

209 If scatterer 2 is perfectly conducting (metallic), then 210 $\bar{Z}_{22} = \bar{P}_{22}, \ \bar{Z}_{12}^{(2)} = [\bar{\mathbf{0}} \ \bar{P}_{12}]^{\mathrm{T}}$ and $\bar{Z}_{21}^{(2)} = [\bar{A}_{21} \ \bar{D}_{21}]$, where 211 $\bar{P}_{ij} = \{\bar{A}_{ij}, \bar{B}_{ij}\}$ for the TM $(\partial \psi_2 / \partial n = 0)$ and TE $(\psi_2 = 0)$ 212 polarizations, respectively. The size of \bar{Z} is reduced to 213 $(2N_1 + N_2) \times (2N_1 + N_2).$

The excitation vector **b** of length $2(N_1 + N_2)$ is written as

$$\boldsymbol{b} = \left[\boldsymbol{b}_1 \ \boldsymbol{0}_{1 \times 2N_2} \right]^{\mathrm{T}}, \qquad (20)$$

where the vector \boldsymbol{b}_1 is defined by Eq. (2). In comparison with Eq. (11), the vector $\boldsymbol{b}_2 = \boldsymbol{0}$ because, as shown in Fig. 1, the scatterer 2 is not illuminated.

218 The unknown vector **X** of length $2(N_1 + N_2)$ is expressed as

$$\boldsymbol{X} = \begin{bmatrix} \boldsymbol{X}_1 \ \boldsymbol{X}_2 \end{bmatrix}^{\mathrm{T}}, \tag{21}$$

219 where X_i is expressed from Eq. (3). The unknown X on $S_1 \cup S_2$ 220 is computed from $X = \overline{Z}^{-1} b$.

221 The scattered field $\bar{\boldsymbol{\psi}}_{sca}(\boldsymbol{r})$ in the medium $\boldsymbol{r} \in \Omega_0$ ($\boldsymbol{r} \notin S_1$) is 222 then obtained from the Huygens principle expressed as

$$\bar{\psi}_{sca}(r) = -\bar{P}(r, r_1)X_1.$$
 (22)

223 If
$$\mathbf{r} \in \Omega_1$$
 ($\mathbf{r} \notin S_1$), then the scattered field $\boldsymbol{\psi}_{sca}(\mathbf{r})$ is

$$\bar{\boldsymbol{\psi}}_{sca}(\boldsymbol{r}) = \begin{bmatrix} +\bar{\boldsymbol{P}}(\boldsymbol{r},\,\boldsymbol{r}_1) \\ -\bar{\boldsymbol{P}}(\boldsymbol{r},\,\boldsymbol{r}_2) \end{bmatrix} \boldsymbol{X}.$$
(23)

224 If $\mathbf{r} \in \Omega_2$ ($\mathbf{r} \notin S_2$), then the scattered field $\bar{\boldsymbol{\psi}}_{sca}(\mathbf{r})$ is

$$\bar{\boldsymbol{\psi}}_{sca}(\boldsymbol{r}) = \bar{\boldsymbol{P}}(\boldsymbol{r}, \boldsymbol{r}_2) \boldsymbol{X}_2.$$
(24)

In this paper, the formulation is generalized to P scatterers. The impedance matrix is then expressed as

$$\bar{Z} = \begin{bmatrix} \bar{Z}_{11} & \bar{Z}_{12}^{(2)} & \bar{\mathbf{0}} & \bar{\mathbf{0}} & \dots & \bar{\mathbf{0}} \\ \bar{Z}_{21}^{(2)} & \bar{Z}_{22} & \bar{Z}_{23}^{(2)} & \bar{\mathbf{0}} & \dots & \bar{\mathbf{0}} \\ \bar{\mathbf{0}} & \bar{Z}_{32}^{(2)} & \bar{Z}_{33} & \bar{Z}_{34}^{(2)} & \dots & \bar{\mathbf{0}} \\ \bar{\mathbf{0}} & \bar{\mathbf{0}} & \bar{Z}_{43}^{(2)} & \bar{Z}_{44} & \dots & \bar{\mathbf{0}} \\ \vdots & \vdots & \ddots & \ddots & \bar{Z}_{P-1,P-1} & \bar{Z}_{P-1,P}^{(2)} \\ \bar{\mathbf{0}} & \bar{\mathbf{0}} & \dots & \bar{\mathbf{0}} & \bar{Z}_{P,P-1}^{(2)} & \bar{Z}_{PP} \end{bmatrix},$$
(25)

where \bar{Z}_{ii} (or $\bar{Z}_{i,i}$) is the self-impedance matrix of the scatterer i,227whereas $\bar{Z}_{ij}^{(2)}$ (or $\bar{Z}_{i,j}^{(2)}$) is the coupling matrix between the objects228i and j (propagation of the scattered field from j to i) expressed229from Eq. (19). Unlike the matrix expressed in Eq. (18), Eq. (25)230shows that only two adjacent scatterers i and $\min(|i + 1|, P)$ 231interact, which explains why null matrices appear.232

The excitation vector \boldsymbol{b} is given by

$$\boldsymbol{b} = \begin{bmatrix} \boldsymbol{b}_1 & \mathbf{0}_{\begin{bmatrix} 1 \times 2 \sum_{i=2}^{j=p} N_i \end{bmatrix}} \end{bmatrix}^{\mathrm{T}}.$$
 (26)

It differs from Eq. (15) because $b_i = 0$ for $i \in [2; P]$ (these scatterers are not illuminated).

The unknown vector \mathbf{X} of length $N = 2 \sum_{i=1}^{i=P} N_i$ is expressed from Eq. (16) and computed by solving the linear system $\mathbf{Z}\mathbf{X} = \mathbf{b}$.

The scattered field $\overline{\Psi}_{sca}(\mathbf{r})$ in the medium $\mathbf{r} \in \Omega_0$ ($\mathbf{r} \notin S_1$) is obtained from the Huygens principle given by Eq. (24). For $\mathbf{r} \in \Omega_i$ ($i \in [1; P-1], \mathbf{r} \notin (S_i \cup S_{i+1})$), the scattered field is

$$\bar{\boldsymbol{\psi}}_{sca}(\boldsymbol{r}) = \begin{bmatrix} +\bar{\boldsymbol{P}}(\boldsymbol{r}, \boldsymbol{r}_i) \\ -\bar{\boldsymbol{P}}(\boldsymbol{r}, \boldsymbol{r}_{i+1}) \end{bmatrix} \begin{bmatrix} \boldsymbol{X}_i \\ \boldsymbol{X}_{i+1} \end{bmatrix}.$$
 (27)

For $\boldsymbol{r} \in \Omega_P$ $(\boldsymbol{r} \notin S_P)$, the scattered field is $\boldsymbol{\bar{\psi}}_{sca}(\boldsymbol{r}) = 242$ $\boldsymbol{\bar{P}}(\boldsymbol{r}, \boldsymbol{r}_P)\boldsymbol{X}_P$. 243

D. Combination of Cases

As an example, in this paragraph, the impedance matrix of the scenario presented in Fig. 4 is determined. It is expressed as

$$\bar{Z} = \begin{bmatrix} \bar{Z}_{11} & \bar{Z}_{12}^{(1)} & \bar{Z}_{13}^{(1)} & \bar{\mathbf{0}} & \bar{\mathbf{0}} \\ \bar{Z}_{21}^{(1)} & \bar{Z}_{22} & \bar{Z}_{23}^{(1)} & \bar{\mathbf{0}} & \bar{\mathbf{0}} \\ \bar{Z}_{31}^{(1)} & \bar{Z}_{32}^{(1)} & \bar{Z}_{33} & \bar{Z}_{34}^{(2)} & \bar{Z}_{35}^{(2)} \\ \bar{\mathbf{0}} & \bar{\mathbf{0}} & \bar{Z}_{43}^{(2)} & \bar{Z}_{44} & \bar{Z}_{45}^{(1)} \\ \bar{\mathbf{0}} & \bar{\mathbf{0}} & \bar{Z}_{53}^{(2)} & \bar{Z}_{54}^{(1)} & \bar{Z}_{55} \end{bmatrix}.$$
(28)

The impedance matrix of scatterers 1, 2, and 3 is expressed 248 from Eq. (14), with P = 3. This explains the first three rows and 249 columns of Z with the superscript (1) (Case 1). The impedance 250 matrix of scatterers 4 and 5 is expressed from Eq. (9), in which 251 the subscripts $\{1, 2\}$ are replaced by $\{4, 5\}$, and the incident 252 medium is Ω_3 . This explains the last two rows and columns of \bar{Z} 253 with the superscript (1) (Case 1). The impedance matrix of scat-254 terers 3 and 4 union 5 is expressed from Eq. (18). This explains 255 the rows (4,5) and columns (4,5) of \overline{Z} with the superscript (2) 256

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Fig. 4. Combination of cases.

- (Case 2). The eight null matrices appear because scatterers 1 and
 26 do not directly interact with objects 4 and 5.
- 259 The excitation vector **b** is given by

$$\boldsymbol{b} = [\boldsymbol{b}_1 \ \boldsymbol{b}_2 \ \boldsymbol{b}_3 \ \boldsymbol{0}_{1 \times 2(N_4 + N_5)}]^{\mathrm{T}},$$
 (29)

for which the scatterers 4 and 5 are not illuminated. It is important to note that, if a source exists in the medium Ω_3 , then b_4 and b_5 differ from **0**. By inverting the matrix Z, the surface currents on the surfaces $\{S_{i \in [1; P]}\}$ are computed.

264 The scattered field $\bar{\Psi}_{sca}(r)$ in the medium $r \in \Omega_0$ 265 $(r \notin (S_1 \cup S_2 \cup S_3))$ is then obtained from the Huygens 266 principle expressed as

$$\bar{\boldsymbol{\psi}}_{sca}(\boldsymbol{r}) = -\begin{bmatrix} \bar{\boldsymbol{P}}(\boldsymbol{r}, \, \boldsymbol{r}_1) \\ \bar{\boldsymbol{P}}(\boldsymbol{r}, \, \boldsymbol{r}_2) \\ \bar{\boldsymbol{P}}(\boldsymbol{r}, \, \boldsymbol{r}_3) \end{bmatrix} \begin{bmatrix} \boldsymbol{X}_1 \\ \boldsymbol{X}_2 \\ \boldsymbol{X}_3 \end{bmatrix}.$$
 (30)

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For $\mathbf{r} \in \Omega_3$ ($\mathbf{r} \notin (S_3 \cup S_4 \cup S_5)$), the scattered field is

$$\bar{\boldsymbol{\psi}}_{sca}(\boldsymbol{r}) = \begin{bmatrix} +\bar{\boldsymbol{P}}(\boldsymbol{r},\,\boldsymbol{r}_1) \\ -\bar{\boldsymbol{P}}(\boldsymbol{r},\,\boldsymbol{r}_4) \\ -\bar{\boldsymbol{P}}(\boldsymbol{r},\,\boldsymbol{r}_5) \end{bmatrix} \begin{bmatrix} \boldsymbol{X}_1 \\ \boldsymbol{X}_4 \\ \boldsymbol{X}_5 \end{bmatrix}.$$
 (31)

268 For $\boldsymbol{r} \in \Omega_4$ ($\boldsymbol{r} \notin S_4$), $\boldsymbol{\bar{\psi}}_{sca}(\boldsymbol{r}) = \boldsymbol{\bar{P}}(\boldsymbol{r}, \boldsymbol{r}_4)\boldsymbol{X}_4$. For $\boldsymbol{r} \in \Omega_5$ ($\boldsymbol{r} \notin S_5$), $\boldsymbol{\bar{\psi}}_{sca}(\boldsymbol{r}) = \boldsymbol{\bar{P}}(\boldsymbol{r}, \boldsymbol{r}_5)\boldsymbol{X}_5$.

In conclusion, the two cases presented in the previous sections
allow us to generalize to any configuration made up of *P* scatterers. To construct the impedance matrix, the following method is
proposed.

For a given scenario, first a boolean interaction matrix \bar{M} of size $P \times P$ is built. If the scatterer j shares a medium Ω_j with the scatterer i, then $M_{ij} = 1, 0$ otherwise. For the case presented in Fig. 4, \bar{M} is written as

$$\bar{\boldsymbol{M}} = \begin{bmatrix} 1 & 1 & 1 & 0 & 0 \\ 1 & 1 & 1 & 0 & 0 \\ 1 & 1 & 1 & 1 & 1 \\ 0 & 0 & 1 & 1 & 1 \\ 0 & 0 & 1 & 1 & 1 \end{bmatrix}.$$
 (32)

278 If $M_{ij} = 0$, then the corresponding matrix $\bar{Z}_{ij} = \bar{0}$. The 279 matrix \bar{M} is symmetric, owing to the reciprocity principle, and 280 $M_{ii} = 1 \quad \forall i \in [1; P].$

281 Second, to distinguish cases of Figs. 2 and 3, for $M_{ij} = 1$, if 282 the scatterer *j* has its surrounding medium $\Omega_{i \neq j, i \neq 0}$ belonging to the medium Ω_i of the scatterer *i*, then $M_{ij} = 2$ [case of Fig. 3, 283 coupling matrix with the superscript (2)], 1 otherwise [case of Fig. 2, coupling matrix with the superscript (1)]. Equation (33) 285 becomes 286

$$\bar{\boldsymbol{M}} = \begin{bmatrix} 1 & 1 & 1 & 0 & 0 \\ 1 & 1 & 1 & 0 & 0 \\ 1 & 1 & 1 & 2 & 2 \\ 0 & 0 & 2 & 1 & 1 \\ 0 & 0 & 2 & 1 & 1 \end{bmatrix}.$$
 (33)

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In conclusion, if $M_{ij} = 0$ then $\bar{Z}_{ij} = \bar{\mathbf{0}}$, $\bar{Z}_{ij} = \bar{Z}_{ij}^{(m_{ij})}$ $(i \neq j)$ 287 otherwise. For the excitation vector \boldsymbol{b} , if the source belongs to 288 the medium $\Omega_{i\in[0;P]}$, then the scatterer set $J = \{j\}$ that shares 289 this medium is illuminated. This means that $\boldsymbol{b}'_J = \psi_{inc}(\boldsymbol{r} \in S_J)$, 290 $\boldsymbol{b}'_{\bar{J}} = \bar{\mathbf{0}}_{1 \times \sum N_{\bar{J}}}$ otherwise, where $\bar{J} = J \notin [1; P]$. The scattered field in medium $\Omega_{i\in[0;P]}$ is computed by using the same 292 methods as those previously addressed. 293

3. CHARACTERISTIC BASIS FUNCTION METHOD

For *P* dielectric scatterers, the size of the matrix to be inverted is $N \times N$, where $N = 2 \sum_{i=1}^{i=P} N_i$. The direct solution of the linear system $\overline{Z}X = b$ through a direct lower upper (LU) decomposition is usually limited by $\mathcal{O}(N^3)$ and $\mathcal{O}(N^2)$ complexities in CPU time and memory requirement, respectively. This is computationally expensive for an electrically large multiscale object or a collection of dielectric objects (i.e., *N* huge). To tackle this issue, the domain decomposition method, named the characteristic basis function method (CBFM), is applied. A summary of this method can be found in [44,45].

It is important to note that, originally, the CBFM was developed for radiation and 3D scattering problems [44] and on a single geometry. Next, it was extended to a single and two 3D dielectric scatterers [40,43].

For a 2D problem, some minor changes are needed.

A. Case of Metallic Scatterers

First, the scatterers are assumed to be metallic. The CBFM312begins by dividing the geometry of the problem to be ana-
lyzed into B blocks, where $\bar{Z}_{i,i}$ is the self-impedance matrix of
the block *i*. Next, a primary basis function (PBF), $Y_{i',k_{\rm IPW}}$, is
computed for each block by solving the linear system312

$$\bar{Z}_{i',i'}Y_{i',k_{\rm IPW}} = B_{i',k_{\rm IPW}},$$
 (34)

where the subscript prime indicates that the block *i* is enlarged317and k_{IPW} stands for the k_{IPW} th plane wave (ranging from 1 to318 $N_{IPW,i}$). The original version of CBFM [44] used $\boldsymbol{B}_{i',k_{IPW}} = \boldsymbol{b}_{i'}$ 319(single incident plane wave, $k_{IPW} = 1$), and the secondary basis320functions (SBFs) are calculated. In 2008 [48], a more efficient321way is proposed to calculate the PBFs, and the computation of322SBFs is not required.323Lucente *et al.* [48] solved the linear system in Eq. (34) from324

Lucente *et al.* [48] solved the linear system in Eq. (34) from a collection of $N_{\text{IPW},i}$ incident plane waves $\{B_{i',k_{\text{IPW}}}\}$, and the resulting vectors $\{Y_{i',k_{\text{IPW}}}\}$ are stored in a matrix \bar{J}_i of size $N_i \times N_{\text{IPW},i}$, where N_i is the number of unknowns of the block *i* without overlapping. This means that the overlapped unknowns of $Y_{i',k_{\text{IPW}}}$ are removed.

The choice of $N_{IPW,i}$ must be relevant to avoid the size of the 330 matrix being too big. The redundant information due to the 331 332 overestimation of $N_{\text{IPW},i}$ is eliminated via the use of a truncated singular value decomposition (SVD). This means that, from 333 a given threshold $\epsilon_{\text{CBFM,SVD}}$, the values for which the mod-334 ulii of the normalized eigenvalues are smaller than $\epsilon_{\text{CBFM,SVD}}$ 335 are removed. The size of \bar{J}_i becomes $N_i \times N_{\text{IPW,SVD},i}$, with 336 $N_{\text{IPW,SVD},i} < N_{\text{IPW},i}$. 337

The last stage of CBFM consists in solving a reduced linear system $\bar{Z}^R a^R = b^R$ defined as

$$\begin{bmatrix} \bar{\boldsymbol{Z}}_{1,1}^{R} & \bar{\boldsymbol{Z}}_{1,2}^{R} & \cdots & \bar{\boldsymbol{Z}}_{1,B}^{R} \\ \bar{\boldsymbol{Z}}_{2,1}^{R} & \bar{\boldsymbol{Z}}_{2,2}^{R} & \cdots & \bar{\boldsymbol{Z}}_{2,B}^{R} \\ \vdots & \vdots & \ddots & \vdots \\ \bar{\boldsymbol{Z}}_{B,1}^{R} & \bar{\boldsymbol{Z}}_{B,2}^{R} & \cdots & \bar{\boldsymbol{Z}}_{B,B}^{R} \end{bmatrix} \begin{bmatrix} \boldsymbol{a}_{1}^{R} \\ \boldsymbol{a}_{2}^{R} \\ \vdots \\ \boldsymbol{a}_{B}^{R} \end{bmatrix} = \begin{bmatrix} \boldsymbol{b}_{1}^{R} \\ \boldsymbol{b}_{2}^{R} \\ \vdots \\ \boldsymbol{b}_{B}^{R} \end{bmatrix}, \quad (35)$$

340 where the submatrix $\bar{Z}_{i,i}^{R}$ and the subvector \boldsymbol{b}_{i}^{R} are defined as

$$\begin{cases} \bar{\boldsymbol{Z}}_{i,j}^{R} = \bar{\boldsymbol{J}}_{i}^{H} \bar{\boldsymbol{Z}}_{i,j} \bar{\boldsymbol{J}}_{j} \left[N_{\text{IPW,SVD},i} \times N_{\text{IPW,SVD},j} \right] \\ \boldsymbol{b}_{j}^{R} = \bar{\boldsymbol{J}}_{j}^{H} \boldsymbol{b}_{j} \left[N_{\text{IPW,SVD},i} \times 1 \right] \end{cases}$$
(36)

Moreover, the symbol H stands for the conjugate transpose operator, and the indexes *i* and *j* range from 1 to *B*. The unknown vector X_i of the block *i* equals $X_i = \bar{J}_i a_i^R$.

The problem is then represented by the characteristic square matrix of size $(B\bar{N}_{\text{IPW},\text{SVD}})^2$ instead of a square matrix of size $N^2 = (B\bar{N})^2$, where $\bar{N} = (1/B) \sum_{p=1}^{B} N_i$ and $\bar{N}_{\text{IPW},\text{SVD}} = (1/B) \sum_{p=1}^{B} N_{\text{IPW},\text{SVD},p}$ (mean values over the number of blocks *B*). Then, the reduction factor is $(\bar{N}/\bar{N}_{\text{IPW},\text{SVD}})^2$. If multiple excitations {**b**} (for instance, monostatic case) are considered, then the storing of \bar{Z}^{R} avoids to repeat the procedure, and the surface currents are calculated rapidly. The complexity of CBFM is detailed in [45].

Originally, the CBFM splits up the single geometry into *B* blocks, since for a 3D problem the number of unknowns can be huge. In this paper, since the number of unknowns N_i of a single scatterer is moderate, it is not required to decompose it into blocks, but it is not a limitation. This means that the number of blocks equals the number of scatterers, B = P, and that the overlapping between the scatterers is not necessary.

360 **B. Case of Dielectric Scatterers**

361As shown by Eq. (1), for a dielectric scatterer, the self-impedance362matrix of size $2N_i \times 2N_i$ is expressed from four submatrices of363size $N_i \times N_i$. Thus, the PFBs are calculated by repeating the364procedure four times used for a metallic object and illustrated by365Eq. (34). This leads to the matrix

$$\bar{J}_{i} = \begin{bmatrix} \bar{J}_{i,11} & \bar{J}_{i,12} \\ \bar{J}_{i,21} & \bar{J}_{i,22} \end{bmatrix},$$
(37)

366 where the submatrices $\{\bar{J}_{i,pq}\}$ $(p = \{1, 2\}, q = \{1, 2\})$ 367 are obtained from the four submatices of $\bar{Z}_{i',i'}$, 368 i.e., $\{\bar{A}_{i',i'}, \bar{B}_{i',i'}, \bar{C}_{i',i'}, \bar{D}_{i',i'}\}$. This representation implies

Table 1. Notations Introduced in This Paper

Name	Definition					
Р	Number of scatterers					
В	Number of blocks $(= P)$					
N	Total number of unknowns					
N_i	Number of unknowns of scatterer <i>i</i>					
$N_{\text{IPW}, p}$	CBFM plane wavenumber of block <i>i</i>					
N _{IPW,SVD,p}	CBFM plane wavenumber of block <i>i</i> after SVD truncation					
$\epsilon_{\rm CBFM,SVD}$	CBFM threshold of the SVD truncation					
\bar{N}	Mean value of N_i over $p \in [1; B]$					
$\bar{N}_{ m IPW}$	Mean value of $N_{\text{IPW},i}$ over $i \in [1; B]$					
$\bar{N}_{\mathrm{IPW,SVD}}$	Mean value of $N_{\text{IPW,SVD},i}$ over $i \in [1; B]$					

that the numbers of plane waves { $N_{\text{IPW},i,pq}$ } of { $J_{i,pq}$ } satisfy $N_{\text{IPW},i,11} = N_{\text{IPW},i,21}$ and $N_{\text{IPW},i,12} = N_{\text{IPW},i,22}$. This means that the size of \bar{J}_i is $2N_i \times (N_{\text{IPW},i,11} + N_{\text{IPW},i,12})$. Like a metallic scatterer, the redundant information is eliminated via the use of a truncated singular value decomposition (SVD). This yields that the new size of \bar{J}_i is $2N_i \times N_{i,\text{IPW}}$, with $N_{i,\text{IPW}} < N_{\text{IPW},i,11} + N_{\text{IPW},i,12}$. Equations (35) and (36) are unchanged.

The SVD decomposition can be applied on each submatrices $\bar{J}_{i,pq}$, and the resulting compressed matrix \bar{J}_i is obtained from Eq. (37). Numerical tests revealed that this procedure has a lower precision than when the SVD is applied on the whole matrix \bar{J}_i .

For convenience, Table 1 lists the notations introduced in this paper.

4. CBFM COMBINED WITH THE KIRCHOFF APPROXIMATION

For a given plane wave $B_{i',k_{\text{IPW}}}$, the calculation of a PBF, $Y_{i',k_{\text{IPW}}}$, requires solving the linear system $\overline{Z}_{i',i'}Y_{i',k_{\text{IPW}}} = B_{i',k_{\text{IPW}}}$, leading to a complexity of $\mathcal{O}(N_{i'}^3)$, where $N_{i'}$ is the number of unknowns with overlapping. To reduce the complexity of this operation to $\mathcal{O}(N_i)$, the Kirchoff approximation (KA) is applied.

For a dielectric scatterer of surface *S* separating two homogeneous media (Ω_1 , Ω_2), the surface current and its normal derivative on $r \in S$ are expressed as [49,50]

$$\begin{cases} \psi(\mathbf{r}) = [1 + \mathcal{R}(\theta)] \psi_{\text{inc}}(\mathbf{r}) \mathcal{I}(\mathbf{r}) \\ \frac{\partial \psi(\mathbf{r})}{\partial n} = [1 - \mathcal{R}(\theta)] \frac{\partial \psi_{\text{inc}}(\mathbf{r})}{\partial n} \mathcal{I}(\mathbf{r}) \end{cases},$$
(38)

where \mathcal{R} is the Fresnel reflection coefficient defined as

$$\mathcal{R} = \begin{cases} \frac{n_2 \cos \theta - n_1 \cos \theta_t}{n_2 \cos \theta + n_1 \cos \theta_t} \text{ TM polarization} \\ \frac{n_1 \cos \theta - n_2 \cos \theta_t}{n_1 \cos \theta + n_2 \cos \theta_t} \text{ TE polarization} \end{cases}.$$
(39)

In addition,
$$\cos \theta = -\hat{k}_{inc} \cdot \hat{n}$$
, $\cos \theta_t = 395$
 $\sqrt{1 - n_1^2 (1 - \cos^2 \theta)/n_2^2}$, and $n_i = \sqrt{\epsilon_{r,i}}$ $(i = \{1, 2\})$ the 396 effection index of the medium Ω_i . The unitary vector \hat{k} 397

refraction index of the medium Ω_i . The unitary vector \mathbf{k}_{inc} 397 stands for the incident direction, and $\hat{\mathbf{n}}$ is the unitary vector 398 normal to the surface at the point \mathbf{r} . In Eq. (38), $\mathcal{I}(\mathbf{r})$ denotes a 399 boolean illumination function. If a point on the surface $\mathbf{r} \in S$ is 400 viewed (that is, $\cos \theta \ge 0$) by the transmitter, then $\mathcal{I}(\mathbf{r}) = 1$; 0 401 otherwise. 402

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403 For a metallic surface, $\mathcal{R} = \{+1, -1\}$ for the TM 404 and TE polarizations, respectively. This leads to $\{\psi =$ 405 $2\mathcal{I}\psi_{inc}, \partial\psi/\partial n = 0\}$ for TM and to $\{\psi = 0, \partial\psi/\partial n =$ 406 $2\mathcal{I}\partial\psi_{inc}/\partial n\}$ for TE.

407 Assuming a plane incident wave $\psi_{inc} = e^{j k_{inc} \cdot r}$, Eq. (38) 408 becomes

$$\begin{cases} \psi(\mathbf{r}) = [1 + \mathcal{R}(\theta)] e^{j\mathbf{k}_{\text{inc}} \cdot \mathbf{r}} \mathcal{I}(\mathbf{r}) \\ \frac{\partial \psi(\mathbf{r})}{\partial n} = [1 - \mathcal{R}(\theta)] e^{j\mathbf{k}_{\text{inc}} \cdot \mathbf{r}} \mathcal{I}(\mathbf{r}) j \mathbf{k}_{\text{inc}} \cdot \hat{\mathbf{n}} \end{cases}$$
(40)

409 In Eq. (37), the PBFs $\{\bar{J}_{i,11}, \bar{J}_{i,12}\}$ are obtained from 410 Eq. (40) by taking $\mathcal{R} = \{+1, -1\}$ (metallic case), respectively, 411 whereas $\{\bar{J}_{i,21}, \bar{J}_{i,22}\}$ are obtained from Eq. (40).

412 In other words, it is equivalent to write that $\overline{Z}_{i,i}$ is a diagonal 413 matrix (because only local interactions are accounted for, that is, 414 the multiple reflections are neglected) by blocks. The two upper 415 blocks have N_i elements equal to $2\mathcal{I}(\mathbf{r}_m)$ and $2\mathcal{I}(\mathbf{r}_m)\mathbf{k}_{inc} \cdot \hat{\mathbf{n}}_m$, 416 respectively, whereas the two lower blocks have N_i elements 417 equal to $\mathcal{I}(\mathbf{r}_m)[1 + \mathcal{R}(\theta_m)]$ (θ_m depends on \mathbf{r}_m discretized on 418 S) and $\mathcal{I}(\mathbf{r}_m)[1 - \mathcal{R}(\theta_m)]\mathbf{j}\mathbf{k}_{inc} \cdot \hat{\mathbf{n}}_m$, respectively.

419 To calculate the PBFs with KA, the resulting complexity 420 is $\mathcal{O}(N_i)$ instead of $\mathcal{O}(N_{i'}^3)$ from a conventional LU decom-421 position. For the numerical results, keep in mind that there is 422 no overlapping between the P = B scatterers, meaning that 423 $N_{i'} = N_i$.

424 5. NUMERICAL RESULTS

In this section, numerical examples are exhibited to demonstrate
the efficiency of CBFM combined with either LU or KA for
the calculation of the PBFs. Table 2 lists parameters of the four
scenarios.

429 A. Scenario 1: Stack of Rough Interfaces

430 First, the scattering from a stack of P = 6 random rough inter-431 faces separating homogeneous media is considered. Table 3 lists 432 the simulation parameters; Fig. 5 shows the scenario.

433 To attenuate the edge diffraction by the upper surface, 434 Thorsos's [51] Gaussian-tapered incident wave is applied with 435 $g = L_1/6 = 10\lambda_0$, and the incident angle is $\theta_{inc} = 0$. The 436 parameter g controls the extend of the incident wave.

437To calculate the PBFs, the incident waves [vectors { $B_{i',k_{\text{IPW}}}$ }438in Eq. (34)] are assumed to be plane, and their incidence angles439range from 0 to 2π . In addition, they are spaced equally and440their number, N_{IPW} , is assumed to be

$$N_{\rm IPW} = \left\lfloor \frac{k_0 D + 1}{n_{\rm IPW}} \right\}, \tag{41}$$

 Table 2.
 Parameters of the Four Scenarios^a

Scenario	$\epsilon_{\text{CBFM},\text{SVD}}$	N	N_R	N _{R,SVD}	t _{LU}	t _{CBFM-LU}	t _{CBFM-KA}
1	10^{-4}	14,400	4,392	2,925	98	20	16
2	10^{-5}	4,074	1096	1036	15	0.6	0.5
3	10^{-4}	11,436	3,336	2,168	48	5	4
4	10^{-5}	11,056	3,326	2,690	81	13	11

"See Table 1 for the notations. In addition, computing times of LU (applied on the entire matrix) t_{LU} , CBFM-LU, $t_{CBFM-LU}$, and CBFM-KA, $t_{CBFM-KA}$ in seconds. The matrix filling time is included.

Table 3. Parameters of the First Scenario: A Stack of P = 6 Random Rough Interfaces Separating Homogeneous Media Ω_i of Permittivity $\epsilon_{r,i}^{a}$

Medium Ω_i	$\epsilon_{r,i}$	Scatterer <i>i</i>	$\sigma_{z,i}[\lambda_0]$	$L_{c,i}[\lambda_0]$	$b_i[\lambda_0]$
0	1				
1	2 + 0.01 j	1	0.1	1	0
2	2.5 + 0.02j	2	0.15	1.5	-2
3	3 + 0.03j	3	0.2	2	-4
4	2 + 0.01j	4	0.1	1	-6
5	2.5 + 0.02j	5	0.15	1.5	-8
6	3 + 0.03j	6	0.2	2	-10

The rough surface number *i* obeys a Gaussian height distribution with a height autocorrelation function (ACF) assumed to be Gaussian, with a standard deviation $\sigma_{x,i}$ and a correlation length $L_{c,i}$. Its height mean value (or depth) is h_i , the surface lengths are equal to $60\lambda_0$, where λ_0 is the wavelength in vacuum (medium Ω_0), and the sampling step per wavelength λ_0 is equal to 20.



Fig. 5. Scenario 1: A stack of P = 6 rough interfaces separating homogeneous media. The simulation parameters are listed in Table 3.

where the symbol \lfloor stands for the upper integer part, D the largest dimension of the scatterer, and $k_0 = 2\pi/\lambda_0$ the wavenumber in vacuum. For $n_{\rm IPW} = 1$, the above equation gives the number of eigen modes that contribute to the scattering from a circular cylinder of diameter D. Since for a rough surface, $N_{\rm IPW}$ is overestimated, the number $n_{\rm IPW} > 1$ is introduced.

Figure 6 plots the modulus of the surface currents { ψ_1 , ψ_6 } (upper and lower interfaces) in dB scale versus the surface abscissa. In the legend, the labels mean "CBFM($\epsilon_{CBFM,SVD}$ - n_{IPW})-LU: $\bar{N}_{IPW} - \bar{N}_{IPW,SVD}$, RRE" (Table 1), where the relative residual error (RRE) is defined as

$$RRE = \frac{\text{norm} (X_{LU} - X_{CBFM})}{\text{norm} (X_{LU})}.$$
 (42)

The norm is the norm 2, which is calculated over the surface abscissa x_i . CBFM-LU means that the PBFs are computed from a LU decomposition. In addition, the legend "LU" means that the strengths are computed from the brute force MoM (LU decomposition of the entire matrix of the problem, that is, the reference solution).

As we can see, for $n_{\rm IPW} = 3$, the results match well with those obtained from LU, and the comparison is better for $\epsilon_{\rm CBFM,SVD} = 10^{-4}$, as expected, but the number $\bar{N}_{\rm IPW,SVD}$ is larger. Table 2 shows that the size of the reduced matrix is 4.9 times smaller than that of the entire problem and the gain in

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Fig. 6. Modulus of the surface current currents $\{\psi_1, \psi_6\}$ (upper and lower interfaces) in dB scale versus the surface abscissa (scenario depicted in Fig. 5). The polarization is TM.



Fig. 7. NRCS in dB scale versus the scattering angle θ_{sca} (scenario depicted in Fig. 5). The polarization is TM.

463 saving time is of the order of 5. Figure 6 also shows that, for 464 $n_{\text{IPW}} = 4$, the results do not coincide with those of LU.

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Figure 7 plots the NRCS in dB scale versus the scattering angle θ_{sca} (scenario depicted in Fig. 5). The polarization is TM. RRE is calculated over the scattering angles θ_{sca} of the field scattered by the upper surface (scatterer 1). As we can see, for $n_{IPW} = 3$, a good agreement is obtained between CBFM and LU, and, for $n_{IPW} = 4$, the disagreement is strong.

471 Figure 8 plots the same variations as in Fig. 7, but the PBFs are computed from LU and KA with $n_{IPW} = 3$. As we can see, 472 for $\epsilon_{\text{CBFM,SVD}} = 10^{-5}$, CBFM-KA predicts satisfactory results, 473 whereas those obtained from CBFM-LU are very good for 474 $\epsilon_{\text{CBFM,SVD}} = 10^{-4}$. However, for $\epsilon_{\text{CBFM,SVD}} = 10^{-6}$, the differ-475 476 ence between LU and CBFM-KA is small. This means that, for a given threshold $\epsilon_{\text{CBFM,SVD}}$, $N_{\text{IPW,SVD}}$ of KA is smaller than 477 that of LU, and, to obtain a similar value between KA and LU, 478 479 $\epsilon_{\text{CBFM,SVD}}$ of KA has to decrease. In other words, the eigenvalue 480 spectrum of PBFs of KA is broader than that of LU. It is impor-481 tant to point out that KA allows us to accelerate the computation of the PBFs because no inversion is needed, unlike LU. 482

483The Kirchoff approximation is valid if the mean surface484curvature radius R_c is greater than the electromagnetic485wavelength [49] (the term $\cos^3\theta$ is omitted). For a Gaussian486ACF [52,53], $R_c \approx L_c^2 (1 + 1.5\sigma_z/L_c)/(2.76\sigma_z) \approx$ 487{4.16, 6.25, 8.33, 4.16, 6.25, 8.33} λ_0 for the surfaces depicted



Fig. 8. NRCS in dB scale versus the scattering angle θ_{sca} (scenario depicted in Fig. 5). The PBFs are computed from LU and KA, with $n_{IPW} = 3$.

in Fig. 5. Numerical results, not depicted in the paper, demonstrate that, when $R_c < \lambda_0$, the precision of CBFM-KA is lower. In addition, it is important to underline that the multiple reflections are neglected with KA, which implies that the surface RMS slope must be moderate (typically, smaller than 0.3–0.35).

Figure 9 plots the same variations as in Fig. 7, but the polarization is TE. For LU, $\epsilon_{\text{CBFM,SVD}} = 10^{-4}$, whereas for KA, $\epsilon_{\text{CBFM,SVD}} = 10^{-6}$. As we can see, a good agreement is obtained with LU, which implies that the input parameters are well chosen.

This first study showed that, for a stack of rough interfaces, the CBFM combined with either LU or KA gives very good results. To calculate the PBFs, Eq. (41) with $n_{\rm IPW} = 3$ slightly overestimates the number of incident plane waves. The use of a SVD truncation allows us to reduce this number by a factor ranging from 1.5 to 1.6 (see Table 2 or legends of Figs. 7–9), which implies that the size of the reduced matrix also decreases. It is also important to underline that the threshold $\epsilon_{\rm CBFM,SVD}$ must be divided by 100 for KA in comparison with LU (with $\epsilon_{\rm CBFM,SVD} = 10^{-4}$) to obtain a similar value of $\bar{N}_{\rm IPW,SVD}$.

B. Scenario 2: Collection of Elliptical Cylinders

In this subsection, the scattering from a collection of 21 ellip-509 tical dielectric cylinders is considered. Figure 10 shows the 510 scenario, in which the cylinders are identical but with a differ-511 ent rotation angle. Their permittivities are $\epsilon_{r,i} = 3 + 0.05 j$, 512 semimajor axis $a = \lambda_0$, and semiminor axis $b = 2\lambda_0$. They 513 are numbered from the left to the right going from bot-514 tom to top (see Fig. 10). Their rotation angles are spaced 515 $\{-180, -162, -144, \ldots, 144, 162, 180\}$ equally as 516 degrees, and the center coordinates are equal to 517 $\{(-6, -2), (-4, -2), (-2, -2), \dots, (2, 2), (4, 2), (6, 2)\}\lambda_0$ 518 519 The sampling step per wavelength λ_0 is 20, and the incident wave is assumed to be plane $\psi_{inc}(\mathbf{r}) = e^{j\mathbf{k}_{inc}\cdot\mathbf{r}} =$ 520 $e^{jk_0(x\sin\theta_{\rm inc}-z\cos\theta_{\rm inc})}$, with an incidence angle $\theta_{\rm inc} = 0$. 521

Figure 11 plots the RCS in dBm scale versus the scattering522angle θ_{sca} (scenario depicted in Fig. 10). The polarization is523TM. In the legend, the labels mean "CBFM($\epsilon_{CBFM,SVD}$ - n_{IPW})-524Method: $\overline{N}_{IPW} - \overline{N}_{IPW,SVD}$, RRE" (Table 1), where the relative525residual error (RRE) is defined by Eq. (42), in which \boldsymbol{X} is the526scattered field in far field versus θ_{sca} . "Method" is the method527



Fig. 9. Same variations as in Fig. 7, but the polarization is TE.



Fig. 10. Scenario 2: Collection of P = 21 elliptical dielectric cylinders.

(LU or KA) applied to compute the PBFs. Figure 11 shows that 528 CBFM matches well with LU; further, in comparison with a 529 rough surface, the threshold $\epsilon_{\text{CBFM,SVD}}$ must be lower (divided 530 531 by 10). The label LU1 means that the self-impedance submatrices $\{Z_{i,i}\}$ and their associated PBFs are calculated only for the 532 scatterer 1, since these functions are invariant by rotation and 533 translation (the elliptical cylinders are identical). This property 534 535 significantly accelerates the first stage of CBFM since the matrices $\{\overline{Z}_{i,i}\}$ and their associated PBFs of the scatterers $i \in [2; P]$ 536 537 are not performed.

538 In Fig. 11, $n_{\text{IPW}} = 1$, and the legend (see also Table 2) indi-539 cates that \bar{N}_{IPW} does not significantly change in comparison 540 with $\bar{N}_{\text{IPW},\text{SVD}}$. This means that the value \bar{N}_{IPW} calculated from 541 Eq. (41) is well chosen and that the SVD truncation could be 542 omitted.

Figure 12 plots the same variation as in Fig. 11, but the polarization is TE. The results of the different methods match well
with those of LU. The number of unknowns and the size of the
reduced matrix for CBFM-LU are reported in Table 2.

For a collection of elliptical cylinders, this second study showed again that the CBFM is efficient and that the value of $N_{\rm IPW}$ expressed by Eq. (41) is well suited. In addition, like for a rough interface (comparison of Fig. 7 with Fig. 9), the TE polarization needs a smaller threshold $\epsilon_{\rm CBFM,SVD}$ than for the TM one to reach a similar RRE.



Fig. 11. RCS in dBm scale versus the scattering angle θ_{sca} (scenario depicted in Fig. 10). The polarization is TM.



Fig. 12. Same variation as in Fig. 11, but the polarization is TE.

C. Scenario 3: Collection of Elliptical Coated Cylinders

In this subsection, the scattering from six elliptical coated dielectric cylinders is considered. Figure 13 shows the scenario. A coated cylinder is composed of three nested cylinders separating four homogeneous media. The scatterers numbered 1, 2, and 3 have semimajor axis $a = \{4, 3, 2\}\lambda_0$, semiminor axis $b = \{3, 2, 1\}\lambda_0$, rotation angles $\{0, 30, 60\}$ degrees, and equal centers of coordinates $(-4.5, 7)\lambda_0$. The permittivities of the four media $\{\Omega_i\}$ $(i \in (1; 4))$ are $\epsilon_r = \{1, 2 + 0.05j, 2.5 + 0.06j, 3 + 0.07j\}$. The scatterers {7, 8, 9} and {13, 14, 15} are obtained from scatterers {1, 2, 3} by making a vertical translation of $-7\lambda_0$ and $-14\lambda_0$, respectively. The remaining scatterers defined for x > 0 are obtained from those defined for x < 0 by symmetry. The sampling step per wavelength λ_0 is 20, and the incident wave is assumed to be plane $\psi_{inc}(\mathbf{r}) = e^{j\mathbf{k}_{inc}\cdot\mathbf{r}} = e^{jk_0(x\sin\theta_{inc}-z\cos\theta_{inc})}$, with an incidence angle $\theta_{inc} = 0$.

Figure 14 plots the RCS in dBm scale versus the scattering angle θ_{sca} (scenario depicted in Fig. 13). The polarization is TM. As we can see, a good agreement is obtained between LU and CBFM-LU and CBFM-KA. Like previously, for KA, the threshold $\epsilon_{CBFM,SVD} = 10^{-6}$ is divided by 100 in comparison with that of LU to select enough PBFs. In Fig. 14, the legend (see also Table 2) indicates that \bar{N}_{IPW} moderately changes in comparison with $\bar{N}_{IPW,SVD}$. This means that the value \bar{N}_{IPW}

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Fig. 13. Scenario 3: Six elliptical dielectric coated cylinders (P = 18 scatterers).



Fig. 14. RCS in dBm scale versus the scattering angle θ_{sca} (scenario depicted in Fig. 13). The polarization is TM.



Fig. 15. Same variation as in Fig. 14, but the polarization is TE.

calculated from Eq. (41) is slightly overestimated and that the SVD truncation allows us to decrease the size of the reduced matrix. In the legend, "CBFM-LU3" means that the PBFs and the self-impedance submatrices { $\bar{Z}_{i,i}$ } are only computed for the scatterers $i = \{1, 2, 3\}$ (first coated cylinder); the other coated cylinders are identical by translation and rotation (same as the second scenario).

Figure 15 plots the same variation as in Fig. 14, but the polarization is TE. In addition, for CBFM-LU, $\epsilon_{\text{CBFM,SVD}} = 10^{-5}$ is divided by 10 in comparison with the TM polarization. The results perfectly match with those obtained from LU.



Fig. 16. Scenario 4: Inhomogeneous rough layer composed of two rough interfaces separated by a collection of 24 elliptical cylinders (P = 26).



Fig. 17. NRCS in dB scale versus the scattering angle θ_{sca} (scenario depicted in Fig. 16). The polarization is TM.

D. Scenario 4: Inhomogeneous Rough Layer

In this subsection, the field scattered by an inhomogeneous rough layer composed of two rough interfaces separated by a collection of 24 elliptical cylinders is presented (P = 26 scatterers).

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As shown in Fig. 16, scatterers 1 and 26 are two independent rough interfaces of length $80\lambda_0$ with standard deviations $\sigma_z = \{0.2, 0.1\}\lambda_0$, height correlation lengths $L_c = \{1, 1.5\}\lambda_0$, Gaussian ACFs, and a Gaussian height distribution. They separate three homogeneous media of permittivities $\epsilon_r = \{2 + 0.01j, 3 + 0.02j, 4 + 0.05j\}$. The 24 cylinders are identical but with different rotation angles. Their permittivities are $\epsilon_{r,i} = 4 + 0.05j$ and have a semimajor axis $a = \lambda_0$ and a semiminor axis $b = 0.5\lambda_0$. They are numbered from left to right going from bottom to top (see Fig. 16). Their rotation angles are spaced equally and range from -180 to 180 with a step of 15.65 deg. The sampling step per wavelength λ_0 is 20. As in scenario 1, to attenuate the edge diffraction by the upper surface, Thorsos's [51] tapered incident wave is applied, with $g = L_1/6$, and the incident angle is $\theta_{inc} = 0$.

Figure 17 plots the NRCS in dB scale versus the scattering angle θ_{sca} (scenario depicted in Fig. 16). The polarization is TM. Figure 18 plots the same variation as in Fig. 17, but the polarization is TE. From Eq. (41), to calculate $N_{IPW,i}$, $n_{IPW} = 1$



Fig. 18. Same variation as in Fig. 17, but the polarization is TE.

614 for the cylinders and $n_{IPW} = 3$, for both rough surfaces. As we 615 can see, a good agreement is obtained between LU and CBFM 616 combined with either LU or KA.

617 6. CONCLUSION

In this paper, the MoM is generalized to several 2D scatterers of any shape; further, the CBFM combined with LU and KA is

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surprising and allows us to simplify the calculation of PBFs. Table 2 shows that the time difference between CBFM-LU and CBFM-KA is small and increases as the number of unknowns grows. As expected, the time is smaller for CBFM-KA. For CBFM-LU, the PBFs are calculated from a LU inversion of complexity $O(N_i^3)$, whereas for CBFM-KA, the complexity is $O(N_i)$. Thus, for large N_i (3D problem), CBFM-KA should be competitive. In addition, with CBFM, the allocation time to calculate the reduced characteristic matrix (second stage common to CBFM-LU and CBFM-KA) is about 80%–90% of the total time. In Table 2, this explains the small differences between $t_{\text{CBFM},\text{LU}}$ and $t_{\text{CBFM},\text{KA}}$.

The advantage of the domain decomposition method is that it is highly parallelizable, which further reduces the computing time. The proposed method is then a powerful electromagnetic computation tool to solve any 2D problem, especially when some scatterers are identical.

APPENDIX A: ELEMENTS OF THE MATRICES

In Eq. (1), the elements (m, n) (indexes of the row and column, 669 respectively) of the submatrices { \bar{A}_{11} , \bar{B}_{11} , \bar{C}_{11} , \bar{D}_{11} } are 670 expressed as (p = q = 1) 671

$$A_{pq,mn} = \begin{cases} -\frac{jk_0v_{q,n}|\Delta_{q,n}|}{4} \frac{H_1^{(1)}(k_0||\mathbf{r}_{q,n}-\mathbf{r}_{p,m}||)}{||\mathbf{r}_{q,n}-\mathbf{r}_{p,m}||} \left[\gamma_{q,n}(x_{q,n}-x_{p,m})-(z_{q,n}-z_{p,m})\right] \text{ for } m \neq n \\ +\frac{1}{2} - \frac{v_{q,n}|\Delta_{q,n}|}{4\pi} \frac{Y_{q,n}'}{1+Y_{q,n}^2} \text{ for } m = n \end{cases},$$
(A1)

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addressed for efficiently solving the resulting linear system. 621 622 Considering four different complex scenarios depicted in 623 Figs. 5, 10, 13 and 16, for both the TM and TE polarizations, the numerical results showed that CBFM-LU and CBFM-624 KA are efficient in terms of computing time and memory 625 requirements in comparison with the brute force MoM (LU 626 decomposition of the entire matrix of the problem). Table 2 627 summarizes the performances of CBFM-LU. For a large num-628 629 ber of unknowns, N, the efficiency is even better since only the self-impedance submatrices are stored for CBFM and the 630 complexity of LU is $\mathcal{O}(N^3)$. 631

The calculation of the number of PBFs, $N_{\text{IPW},i}$ given by 632 633 Eq. (41), is well suited. For a rough surface, $n_{IPW} = 3$ and for an 634 elliptical cylinder, $n_{\rm IPW} = 1$. To reduce the size of the reduced matrix, a SVD truncation can be applied; for elliptical cylinders, 635 however, it is not useful because $N_{\text{IPW},i,\text{SVD}}$ is of the same order 636 of $N_{\text{IPW},i}$. For a collection of objects invariant by translation 637 638 and rotation, another advantage of CBFM is that the PBFs 639 and the self-impedance submatrices of the scatterers are equal. Therefore, the first stage of CBFM is applied only on a single 640 641 scatterer.

To accelerate the computation of the PBFs, that is, to avoid 642 an LU decomposition on the self-impedance submatrices, KA is 643 644 applied. The numerical results showed that CBFM-KA matches 645 well with LU, but in comparison with CBFM-LU, the threshold 646 $\epsilon_{\text{CBFM,SVD}}$ must be divided by 100 to obtain a comparable value of $N_{\text{IPW},i}$. It is important to point out that CBFM-KA predicts 647 648 good results, even on geometries for which KA is not valid, like the elliptical cylinders. In addition, in Eq. (38), the boolean 649 illumination function $\mathcal{I}(\mathbf{r})$ can be omitted. This statement is 650

$$B_{pq,mn} = \frac{j |\Delta_{q,n}| \sqrt{1 + \gamma_{q,n}^2}}{4} \\ \begin{cases} H_0^{(1)}(k_0 \| \mathbf{r}_{q,n} - \mathbf{r}_{p,m} \|) & \text{for } m \neq n \\ \left[1 + \frac{2j}{\pi} \ln \left(0.164k_0 \sqrt{1 + \gamma_{q,n}^2} |\Delta_{q,n}| \right) \right] & \text{for } m = n' \end{cases}$$
(A2)

$$C_{pq,mn} = \begin{cases} A_{pq,mn} \mid_{k_0 = k_1} & \text{for } m \neq n \\ -\frac{1}{2} - \frac{v_{q,n} \mid \Delta_n \mid}{4\pi} \frac{\gamma'_{q,n}}{1 + \gamma^2_{q,n}} & \text{for } m = n \end{cases},$$
(A3)

$$D_{pq,mn} = \frac{B_{pq,mn} \mid_{k_0 = k_1}}{\rho_{01}}.$$
 (A4)

where $\mathbf{r}_{q,n} = (x_{q,n}, z_{q,n}) \in S_q$ (coordinates of the point on the surface S_q), $\mathbf{r}_{p,m} = (x_{p,m}, z_{p,m}) \in S_p$, $\gamma = dz/dx$, $\gamma' = d\gamma/dx$, $\Delta_{q,n}$ the sampling step on S_q , $v_{q,n} = \operatorname{sgn}(\hat{\mathbf{n}}_{q,n} \cdot \hat{\mathbf{z}})$ $(\hat{\mathbf{n}}_{q,n}$ is the unitary vector normal to the surface S_q at the point $\mathbf{r}_{q,n}$), $\mathbf{H}_0^{(1)}$ the zeroth order Hankel function of the first kind and $\mathbf{H}_1^{(1)}$ its derivative.

For the TE polarization, the variable $\rho_{01} = 1$, whereas for the TM polarization, $\rho_{01} = \epsilon_{r,0}/\epsilon_{r,1}$, where $\epsilon_{r,i}$ is the relative permittivity of medium Ω_i .

It is important to underline that, for a self (interaction of the same surface) impedance submatrix, p = q and a singularity occurs for m = n, whereas for a coupling matrix $p \neq q$, there is no singularity because $\mathbf{r}_p \neq \mathbf{r}_q$. In addition, any matrix \mathbf{Z}_{pq} propagates the field from the source points $\{\mathbf{r}_{q,n}\}$ toward the observation points $\{\mathbf{r}_{p,m}\}$.

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For the calculation of the scattered field in the far field 690 691 $(u \to \infty)$, the following expansions [6] of the Hankel functions can be applied: 692

$$\begin{cases} H_0^{(1)}(u) \approx \sqrt{\frac{2}{\pi u}} \exp\left[j\left(u - \frac{\pi}{4}\right)\right] \\ H_1^{(1)}(u) = -j H_0^{(1)}(u) \end{cases}$$
(A5)

693 Disclosures. The authors declare no conflicts of interest.

694 Data Availability. Data underlying the results presented in this paper are 695 not publicly available at this time but may be obtained from the authors upon 696 reasonable request.

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